



IEC QUALITY ASSESSMENT SYSTEM (IECQ)

For rules and details of the IECQ visit www.iecq.org

IECQ Certificate of Conformity IECQ ESD (Electro Static Discharge)

IECQ Certificate No.: IECQ-P JQAJP 26.0001

Issue No.: 1

Status: **Current**

Supersedes:

Issue date: **2026-06-22** Initial: **2026-06-22**

CB Reference No.: JQAQ0022-001-E

Expiration: **2029-06-21**

Applicant: **Tera Probe, Inc. Kyushu Operation Center**
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The organization has established and implemented procedures and related processes that have been assessed by the IECQ Conformity Assessment Body in accordance with IECQ 03-1 and IECQ 03-2 for issuance of this certificate and found to be in conformity with the applicable requirements of the IECQ Approved Process Scheme and in respect of standard(s) or specification(s):

- **IECQ AS 032000-JP0001 {ed1.0}** IEC Quality Assessment System for Electronic Components (IECQ System) - Assessment Specification - Protection of electronic devices from electrostatic phenomena – General requirements
- **Attached Schedule**

Process Manual Reference: TJP-0001 Rev. 50 2025-08-29

-- Attached plan(s): none

Scope of process activities:

ESD Control Processes for designated EPA Areas for Wafer Test and Final Test Operations at the Kyushu Operation Center of Tera Probe, Inc.

-- Attached schedule(s): IECQ-P JQAJP 26.0001-01_S.pdf

Issued by: **Japan Quality Assurance Organization (JQA)**
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Schedule of Scope to Certificate of Conformity

IECQ Certificate No.: IECQ-P JQAJP 26.0001

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Schedule Number: IECQ-P JQAJP 26.0001-S

Rev No.: 1

Revision Date: 2026/06/22

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Assessment Specification number:

IECQ-AS 032000-JP0001

for use within the

IECQ Approved Process Scheme –ESD (IECQ AP ESD)

Document title registered as this specification:

RCJS-5-1(Edition 3): 2016, Protection of
electronic devices from electrostatic phenomena-
General requirements.

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